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Space systems — Lunar simulants

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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The main task of technical committees is to prepare International Standards. Draft International Standards adopted by the technical committees are circulated to the member bodies for voting. Publication as an International Standard requires approval by at least 75 % of the member bodies casting a vote.

ISO 10788 was prepared by Technical Committee ISO/TC 20, *Aircraft and space vehicles*, Subcommittee SC 14, *Space systems and operations*.

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Introduction

This International Standard provides lunar systems developers and operators with a specific quantitative measure for lunar regolith simulants in comparison to other simulants and with relation to sampled lunar materials from Apollo and Lunakhod missions. Developers of lunar systems will use simulants as test materials. This International Standard is a reference for quantitative measures of lunar simulants finer than 10 μ m. The quantitative measures of lunar dust simulants are based on the quantitative measures of lunar regolith samples collected at multiple lunar landing sites of the Apollo missions.

This standard provides communication of the geological quality of the simulant between developing organizations and systems operations organizations.

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Space systems — Lunar simulants

1 Scope

This International Standard is a reference for quantitative measures of lunar simulants. The quantitative measures of lunar simulants are based on the quantitative measures of lunar samples collected at multiple lunar landing sites of the Apollo and Lunakhod missions.

2 Normative references

The following normative documents contain provisions which, through reference in this text, constitute provisions of this part of ISO 10788. For dated references, subsequent amendments to, or revisions of, any of these publications do not apply. However, parties to agreements based on this part of ISO 10788 are encouraged to investigate the possibility of applying the most recent editions of the normative documents indicated below. For undated references, the latest edition of the normative document referred to applies. Members of ISO and IEC maintain registers of currently valid International Standards.

Heiken, G., D. Vaniman, et al. (1991). Lunar Sourcebook: A User's Guide to the Moon[®]. Cambridge [England] ; New York, Cambridge University Press. ISSN No. 1540-7845. The Lunar Sourcebook[®] is a recognized international compendium of lunar information collected through the Apollo era.

Klaus K.E. Neuendorf, James P. Mehl, Jr., and Julia A. Jackson, editors. Glossary of Geology, 5th edition, American Geological Institute, ISBN 0-922152-76-4.

3 Terms and definitions and abbreviated terms

3.1 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

3.1.1

agglutinate

vesiculated glass bonded particle containing other particles (lithic fragments), of which the bonding glass contains spherical particles of iron. The lunar spherules are typically 3 – 100 nanometers in diameter and formed contemporaneous with the glass. Six features characterize lunar agglutinates: size, surface area with relation to volume, composition, nanophase iron content, flow banding and multiple generations.

3.1.2

angularity

an expression of roundness (i.e., a poorly rounded grain is described as angular), from the Glossary of Geology

3.1.3

aspect ratio

ratio of the maximum Feret diameter divided into the orthogonal Feret diameter. Values range from >0 to 1 and equal 1 for a circle.

3.1.4

feret diameter

distance between two parallel lines which are tangent to the perimeter of a particle. The maximum Feret diameter is defined as the greatest distance between two parallel lines which are still tangent to the perimeter of the particle.

3.1.5

figure of merit

degree to which a sample matches a reference. Scaling (normalization) forces the norm of the difference of two composition vectors to lie between 0 and 1, and subtraction from unity results in a figure of merit of 1 for a perfect match and 0 for not match at all.

3.1.6

Heywood circularity factor

expression of the complexity of a particle's perimeter. Formally, the Heywood Circularity Factor is equal to 1 divided by particle perimeter divided by the circumference of a circle with the same area as the particle. This is numerically equal to the "circularity" defined by Wadell (1933). It is expressed in this manner to make it apparent that the Heywood factor is the inverse of a common definition of "circularity", another common measure. Values range from >0 to 1 and equal 1 for a circle.

3.1.7

lithic fragments

physically discrete solids of any rock type whose normative composition is within the range of the target terrain. Lithic fragments have texture and mineralogy. Texture is a more important feature than mineralogy for lithic fragments. Texture describes the grain to grain connectivity boundary. Lunar textures cannot be replicated on Earth.

3.1.8

lunar terrains

Mare and Highlands

3.1.9

regolith

all particulate surface material including rocks, soils and dust. As stated in the Introduction, this standard is limited in scope to regolith 10cm and smaller. Rocks, soils and dust are not differentiated on the basis of size.

3.1.10

re-use

after a simulant volume is used (any sequence of events in which a simulant volume is removed from a storage container) then placed back into storage, any future use constitutes re-use.

3.1.11

sphericity

degree to which the shape of a particle approaches a sphere

3.2 Abbreviated terms

c_x	the concentration, or portion, of a sample for the x^{th} item in the sample.
FoM	Figure of Merit
RFD	Relative Frequency Distribution
w_i	a weighting factor. w is a value between one and zero. i is an index which refers to the characteristic being weighted, such as glass (a grain type)

4 Characteristics of Lunar Regolith Previously Defined in the Lunar Sourcebook[®]

4.1 Minerologies

The lunar surface mineralogy is variable across major terrain. These properties are qualitative; they cannot be described in a quantitative manner related to any known spatial distribution across the lunar surface. A listing of the primary minerologies in the Lunar Sourcebook[®] is:

Silicate minerals such as Pyroxene, Plagioclase Feldspar, Olivine (Fo₈₀), and Silica minerals.

Oxide minerals such as Ilmenite, Spinel, and Armalcolite

Sulfide Minerals such as Troilite

Native Fe

Phosphate Minerals

4.2 Physical and chemical Properties

The Lunar Sourcebook[®] provided a compilation of properties from Apollo and Lunakhod lunar samples of use to the scientific community. These properties are listed since a large amount of data exists for lunar regolith characterization using these properties. As demanded by scientific definitions, these properties are qualitative and quantitative. This means some properties can be measured directly while others are descriptive and are not readily measurable. While these properties are of value to planetary or lunar scientists they do not address the needs of lunar systems developers and operators with a specific quantitative measure for lunar regolith simulants in comparison to other simulants and with relation to sampled lunar materials.

4.2.1 Physical properties

4.2.1.1 Geotechnical properties

- a) Particle Size Distribution
- b) Particle Shapes
- c) Specific Gravity
- d) Bulk Density
- e) Porosity
- f) Relative Density
- g) Compressibility
- h) Shear Strength
- i) Permeability and Diffusivity
- j) Bearing Capability
- k) Slope Stability
- l) Trafficability

4.2.1.2 Electrical and electromagnetic properties

- a) Electrical conductivity
- b) Photoconductivity
- c) Electrostatic Charging
- d) Dielectric Permittivity

4.2.2 Chemical properties

- a) Major Elements
- b) Incompatible Trace Elements
- c) Miscellaneous Minor Elements
- d) Siderophile Elements
- e) Vapor-Mobilized Elements
- f) Solar Wind Implanted Elements

5 Quantitative measurement properties of lunar simulants

Lunar simulants may be measured as lunar samples were measured and published using 22 listed properties (reference section 4). However, the quality of lunar simulants measured in this way cannot be readily compared to lunar source material nor communicated across development and operational communities. Comparison of these measures for simulants for other than scientific purposes is not recommended.

The more useful qualification of lunar simulants is tied to lunar mineralogies and is expressed most concisely in four figures of merit: Composition, Size, Shape and Density. The figures of merit for lunar simulants range from zero to one. A figure of merit value of zero indicates no useful correlation to a comparative sample. A figure of merit value of one indicates exact correlation as defined by the standard measurements to a comparative sample. A specific quantitative measure for lunar regolith simulants is made only in comparison to other simulants or with relation to sampled lunar materials from Apollo and Lunakhod missions. Data from existing lunar samples are necessary to use these figures of merit to establish a real baseline from the lunar surface.

5.1 Comparative baseline

Comparative (quantitative) measures shall be stated for lunar simulants. Figures of merit for a simulant shall be stated against a single baseline. If multiple baselines are referenced for a simulant a complete set of figures of merit shall be calculated for each reference.

5.2 Impurities and contamination

Simulants may not be completely defined by these Figures of Merit for reasons of mineralogical impurity and contamination of the simulant by organic/inorganic materials.

Impurity of the sample/simulant measured shall be stated in percent of the sample mass.

Contamination of the sample/simulant shall be stated in percentage of the sample volume. Characterization of the sample contamination and the nature of that contamination shall be stated if an analysis is performed.

5.3 Validation of Figures of Merit

Calculation of figures of merit for a simulant shall be performed and recorded for each use. In the event a volume of simulant is re-used, the figures of merit shall be recalculated in accordance with this standard. Scaling (normalization) forces the norm of the difference of two composition vectors to lie between 0 and 1, and subtraction from unity results in a figure of merit of 1 for a perfect match and 0 for not match at all.

5.4 Composition Figure of Merit

5.4.1 Composition Figure of Merit (FoM) Equation

The Figure of Merit definition is

$$FoM = 1 - \frac{\|w_{adjusted} (c_{adjusted reference} - c_{adjusted simulant})\|_1}{\|[\max_1(w_{adjusted}) \max_2(w_{adjusted})]\|_1}$$

where w_i is used to adjust the figure of merit for a particular grain type (see 5.4.3) and $\max_i(w)$ is the i^{th} largest element of w . This form of the Figure of Merit is not useful in actual calculation. The Figure of Merit equation for calculation shall be

$$FoM = 1 - \frac{\sum_i w_{adjusted_i} |c_{adjusted reference_i} - c_{adjusted simulant_i}|}{\sum_i w_{adjusted_i} c_{adjusted reference_i} + \sum_i w_{adjusted_i} c_{adjusted simulant_i}}$$

For example, in the constituent example table below normalized concentrations for basalt are given for both the sample and the simulant (approximately 0.015 and 0.120, respectively). In the difference table it is further shown that the basalt difference is 0.105 with a higher concentration in the simulant.

Table 1 — Constituent example table

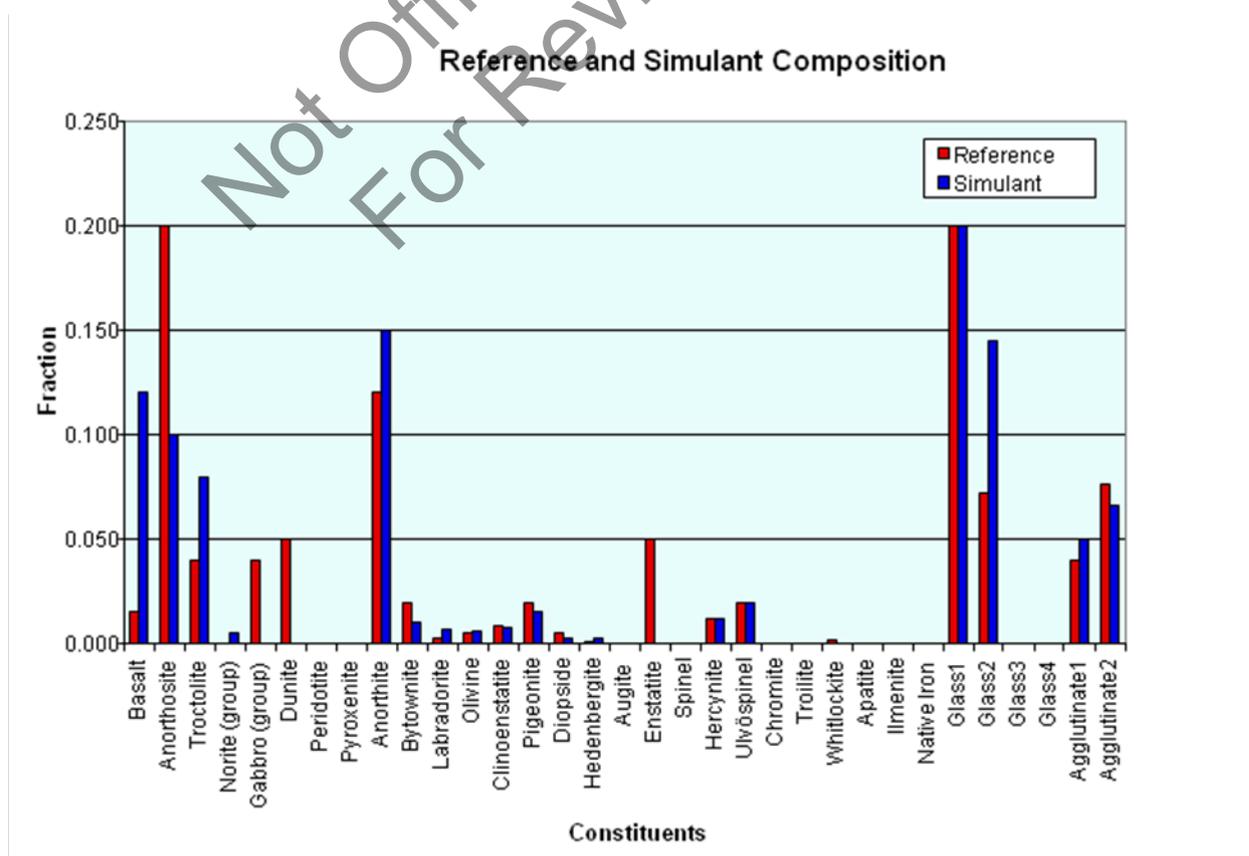
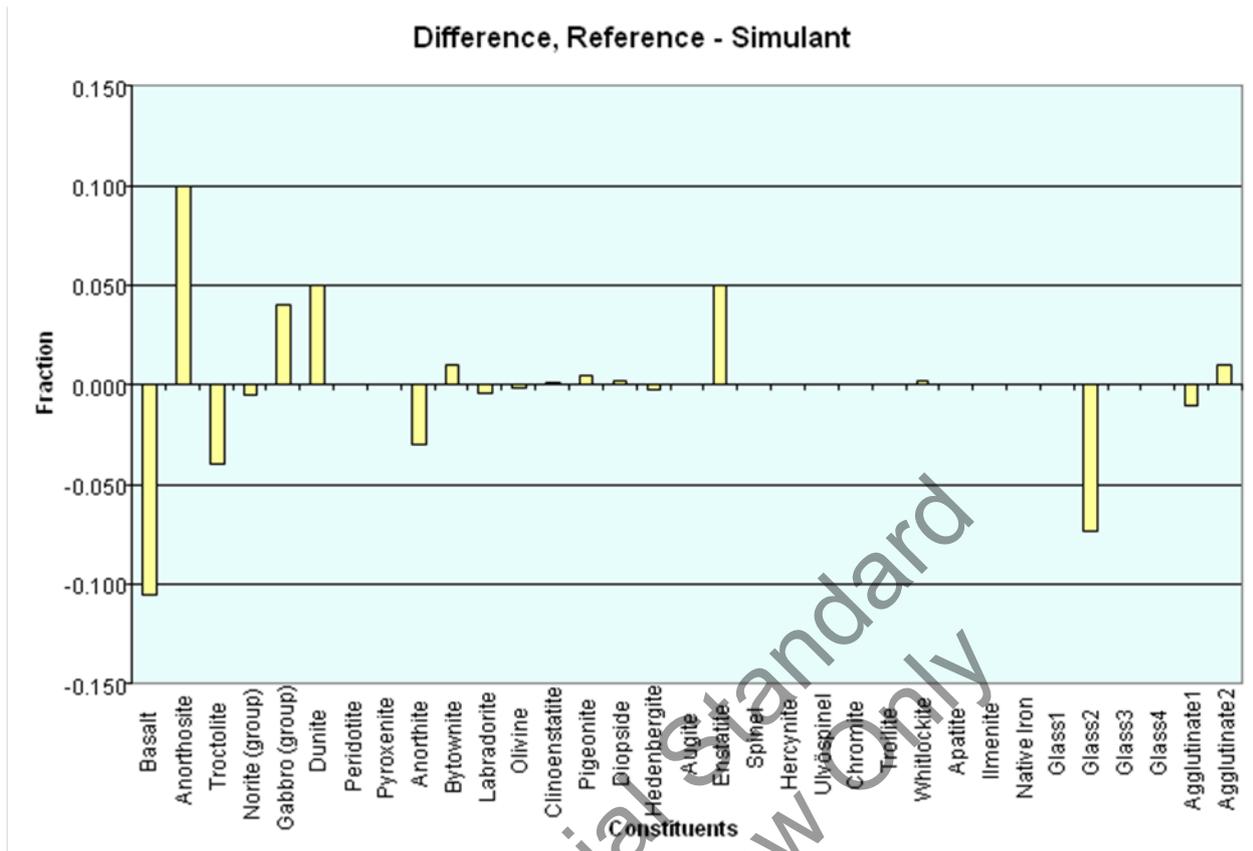


Table 2 — Difference table



5.4.2 Particles

Compositions are defined for particles. A particle may be made up of one or more grains. A particle may be composed of a combination of crystalline solids, glass, or a mixture of these and may contain voids. The smallest particle is a single grain of material.

5.4.3 Grain types

Grain types shall be described as crystalline solids (agglutinates, lithic fragments) or glass.

5.4.3.1 Crystalline Solids

Crystalline solids shall have structure at the level of an X-ray.

5.4.3.2 Glasses

Glasses shall be made from the rest of the material in the simulant

Glasses shall have a normative mineralogy within the range of the moon.

5.5 Size Distribution Figure of Merit

5.5.1 Size Distribution FoM Equation

The calculation of the size distribution figure of merit shall be

$$F_{b, o_{ec}, f_{oid}, M_{avr}, l_{se}} = \frac{\sqrt{\int w(R_r, F_r, R_e, D_s, e, F_m)^2}}{\sqrt{\int w_r^2 R_e + \int w_r^2 D R_i m}}$$

with the further constraint

$$F_{b, o_{ec}, f_{oid}, M_{avr}, l_{se}} \leq \frac{R_{o_{ec}} f_{oid} M_{avr} l_{se}}{R_{o_{ec}} f_{oid} M_{avr} l_{se}}$$

In the reference and simulant size distribution example table below RFD values for reference and simulant are given for the 0.1 cm size at 0.08 and 0.02 respectively.

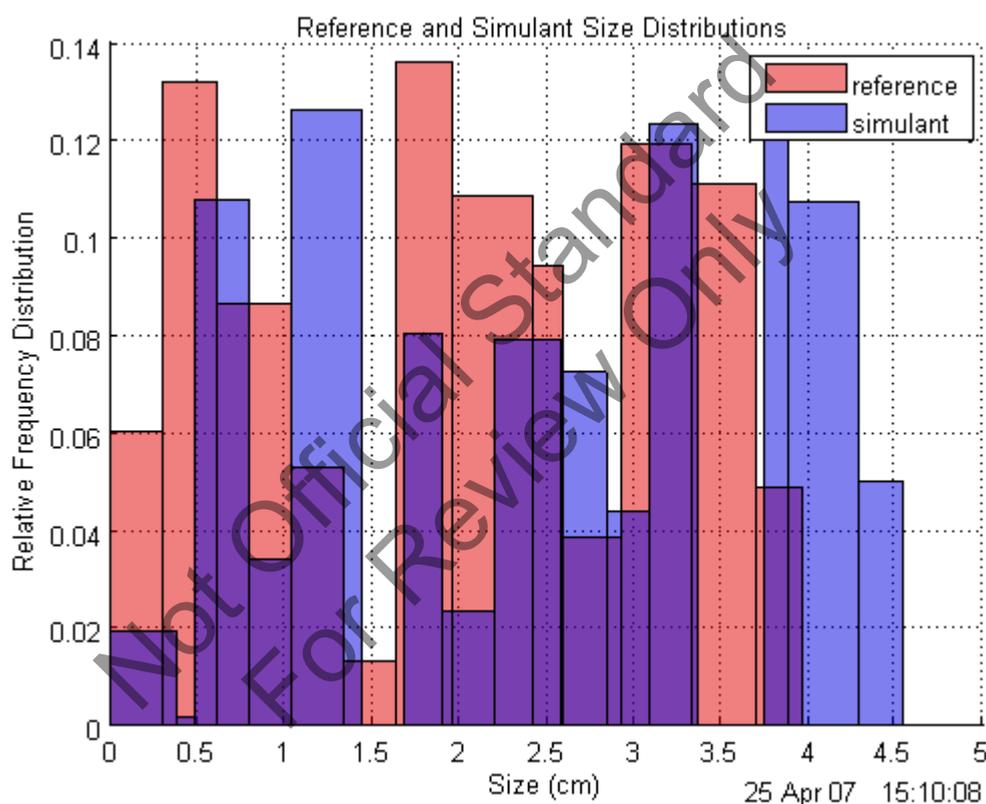


Figure 1 — Reference and simulant size distributions

5.5.2 Particles from 4 cm to 75 microns

Particles from 4 cm to 75 microns shall be measured by the method of sieving.

5.5.3 Particles from 100 microns to 1 micron

Particles of Apollo and simulant materials between 100 microns and 1 micron shall be analyzed by the method of optical imaging.

5.5.4 Particles finer than 2 microns

Particles finer than 2 microns shall be measured by the method of aerosol dispersion.

5.6 Shape Figure of Merit

5.6.1 Shape FoM Equation

The calculation of the shape figure of merit shall be the product of the FoM for Sphericity (Heywood Circularity Factor using automated systems) and FoM for Angularity (Aspect Ratio using automated systems).

$$F_{b_{ec}} = \frac{\sqrt{\int w(R_r F_r R_e D_s e F_m)^2}}{\sqrt{\int w R_e^2 + \int w R_e^2 DR_{in}}}$$

with the further constraint

$$F_{b_{ec}} = \frac{F_{b_{ec}}}{0} \left| \frac{R_{oo} f M_{rn e} - R_{sf s e t}}{o t h} \right| \leq \frac{m D_a R_{in}}{D_{le} a t}$$

5.6.2 Shape

Shape shall be determined by the combined sphericity and angularity of the particles.

Shape is conventionally defined on a particle by particle basis by shape specialists in the scientific field of Geology using a combination of sphericity and angularity of the particles. An equivalent method for determining shape of a large number of particles in a sample by automated devices and computer analysis use the Heywood Circularity Factor and aspect ratio (dependent on the Feret Diameter).

5.6.2.1 Sphericity

Sphericity shall be determined to define particle shape. If automated devices and computer analysis are used this distribution shall use the Heywood Circularity Factor.

5.6.2.2 Angularity

Angularity shall be determined to define particle shape. If automated devices and computer analysis are used this distribution shall use the Aspect Ratio.

5.7 Density Figure of Merit

5.7.1 Density FoM Equation

The figure of merit for how closely a simulant matches a reference is proportional to the ratio of the densities. Ratios of less than (1-density quotient limit) or greater than (1+density quotient limit) correspond to an FoM of 0, while a ratio of 1 corresponds to an FoM of 1. The density figure of merit shall be calculated as

$$\frac{1}{\text{density_quotient_limit}} \left(\frac{\text{simulant_density}}{\text{reference_density}} \right) + \frac{\text{density_limit} - 1}{\text{density_quotient_limit}}$$

$$\text{for } 1 - \text{density_quotient_limit} \leq \frac{\text{simulant_density}}{\text{reference_density}} < 1$$

$$\frac{-1}{\text{density_quotient_limit}} \left(\frac{\text{simulant_density}}{\text{reference_density}} \right) + \frac{\text{density_limit} + 1}{\text{density_quotient_limit}}$$

$$FoM = \text{for } 1 \leq \frac{\text{simulant_density}}{\text{reference_density}} < 1 + \text{density_quotient_limit}$$

0_ otherwise

5.7.2 Measurement

Density shall be measured by taking a sufficiently large enough sample so that the sample follows the particle size distribution of the material as defined in the baseline for Size Distribution (see 5.5).

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